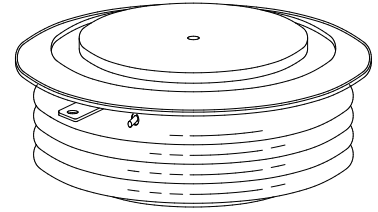

T11C




Device Type	V_{RRM} (1)	V_{DRM} (1)	V_{RSM} (1)
KP2600/12	1200	1200	1400
KP2600/14	1400	1400	1600
KP2600/16	1600	1600	1760
KP2600/18	1800	1800	1900

V_{RRM} = Repetitive peak reverse voltage
 V_{DRM} = Repetitive peak off state voltage
 V_{RSM} = Non repetitive peak reverse voltage (2)

Repetitive peak reverse leakage and off state leakage	I_{RRM}/I_{DRM}	5 mA 150 mA (3)
Critical rate of voltage rise	dv/dt (4)	1000 V/ s

Notes:

- (1) All voltage ratings are specified for an applied 50Hz sinusoidal waveform over the temperature range -40 °C to +125 °C.
- (2) 10 msec. max. pulse width
- (3) Maximum value for $T_j = 125$ °C.
- (4) Minimum value for linear and exponential waveshape to 67% rated V_{DRM} . Gate open. $T_j = 125$ °C.
- (5). The value of di/dt is established in accordance with EIA/NIMA Standard JB/T 8950.2-2013



Peak gate power dissipation

P_G

